

FEATURES

- Offers Bandwidth Allocation of PCI Express™ Signal Using Two-Lane 1:2 Multiplexer/Demultiplexer
- Vcc Operating Range From 1.7 V to 1.9 V
- Supports Data Rates of 2.5 Gbps
- Port-Port Crosstalk (–39 dB at 1.25 GHz)
- OFF Port Isolation (–38 dB at 1.25 GHz)
- Low ON-State Resistance (10 Ω Typ)
- Low Input/Output Capacitance (3.5 pF Typ)

- Excellent Differential Skew (5 ps Max)
- Minimal Propagation Delay
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)

DESCRIPTION/ORDERING INFORMATION

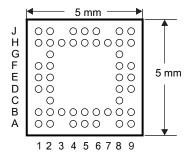
The TS2PCIE2212 can be used to muxltiplex/demultiplex two PCI Express™ lanes, each representing differential pairs of receive (RX) and transmit (TX) signals. The switch operates at the PCI Express bandwidth standard of 2.5-Gbps signal-processing speed. The device is composed of two banks, with each bank accommodating two sources (source A and source B) and two destinations (destination A and destination B).

When a logic-level low is applied to the control (CTRL) pin, source A is connected to destination A and source B is connected to destination B. When a logic-level high is applied to CTRL, source A is connected to destination B, while source B and destination A are open.

ORDERING INFORMATION

T _A	PACI	KAGE	ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 85°C	BGA – ZAH	Tape and reel	TS2PCIE2212ZAHR	

ZAH PACKAGE (BOTTOM VIEW)



TERMINAL ASSIGNMENTS

	1	2	3	4	5	6	7	8	9
Α	CTRL0	TxSB:0P		TxSA:0P	GND	TxDA:0P		TxDB:0P	NC
В	RxSA:0P	GND	TxSB:0N	TxSA:0N	VDD	TxDA:0N	TxDB:0N	GND	RxDA:0P
С		RxSA:0N						RxDA:0N	
D	RxSB:0P	RxSB:0N						RxDB:0N	RxDB:0P
E	GND	VDD						VDD	GND
F	TxSA:1P	TxSA:1N						TxDA:1N	TxDA:1P
G		TxSB:1N						TxDB:1N	
Н	TxSB:1P	GND	RxSA:1N	RxSB:1N	VDD	RxDB:1N	RxDA:1N	GND	TxDB:1P
J	NC	RxSA:1P		RXSB:1P	GND	RXDB:1P		RxDA:1P	CTRL1

Please be aware that an impo Instruments semiconductor pr PCI Express is a trademark of PCI-SIG.

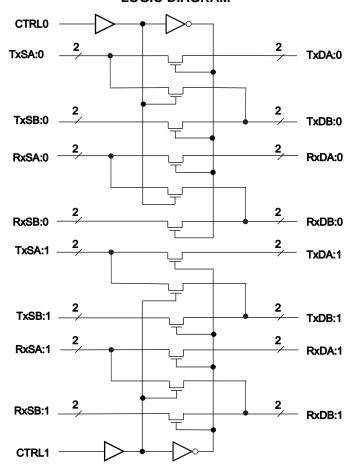
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



PIN DESCRIPTION

NAME	FUNCTION
TxSA:nP, TxSA:nN	Source A transmit pair
RxSA:nP, RxSA:nN	Source A receive pair
TxSB:nP, TxSB:nN	Source B transmit pair
RxSB:nP, RxSB:nN	Source B receive pair
TxDA:nP, TxDA:nN	Destination A transmit pair
RxDA:nP, RxDA:nN	Destination A receive pair
TxDB:nP, TxDB:nN	Destination B transmit pair
RxDB:nP, RxDB:nN	Destination B receive pair
CTRL0	Control signal for bank 0
CTRL1	Control signal for bank 1
V_{DD}	Positive supply voltage
GND	Ground (0 V)
NC	No internal connection

LOGIC DIAGRAM





SCDS209-JUNE 2006

FUNCTION TABLE

CTRLn	FUNCTION
L	SA:n = DA:n, SB:n = DB:n
Н	SA:n = DB:n, DA:n = open, SBin = open

Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

				MIN	MAX	UNIT
V_{DD}	Supply voltage range		-0.5	2.5	V	
V _{IN}	Control input voltage range ⁽²⁾⁽³⁾			-0.5	2.5	V
V _{I/O}	Switch I/O voltage range ⁽²⁾⁽³⁾⁽⁴⁾				2.5	V
I _{IK}	Control input clamp current	$V_{IN} < 0$ and $V_{I/O} < 0$			50	mA
I _{I/OK}	I/O port clamp current	V _{IN} < 0 and V _{I/O} < 0			50	mA
I _{I/O}	ON-state switch current ⁽⁵⁾				±100	mA
	Continuous current through V _{DD} or GND				±100	mA
θ_{JA}	Package thermal impedance ⁽⁶⁾				TBD	°C/W
T _{stg}	Storage temperature range			-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

All voltages are with respect to ground, unless otherwise specified.

Recommended Operating Conditions

			MIN	TYP	MAX	UNIT
V_{DD}	Supply voltage		1.7	1.8	1.9	V
V_{IH}	High-level control input voltage	CTRL	0.65 V _{DD}			V
V _{IL}	Low-level control input voltage	CTRL			0.35 V _{DD}	V
V _{IO}	Data input/output voltage		0		V_{DD}	V
T _A	Operating free-air temperature		0		85	°C

The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

⁽⁴⁾ V_1 and V_0 are used to denote specific conditions for $V_{1/0}$.

 ⁽⁵⁾ I_I and I_O are used to denote specific conditions for I_{I/O}.
(6) The package thermal impedance is calculated in accordance with JESD 51-7.



Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS		T _A = (0°C to 8	35°C	LINUT
			MIN TYP		MAX	UNIT		
V _{IK}	Control inputs	V _{DD} = 1.7 V,	$I_{IN} = -18 \text{ mA}$				-1.8	V
I _{IN}	Control inputs	V _{DD} = 1.9 V,	$V_{IN} = V_{DD}$ or GND				±1	μΑ
I _{OZ}		V _{DD} = 1.9 V,	$V_O = 0 \text{ to } 1.9 \text{ V},$ $V_I = 0,$	Switch OFF			±5	μΑ
I _{CC}		$V_{DD} = 1.9 \text{ V},$ $V_{IN} = V_{DD} \text{ or GND},$	$I_{I/O} = 0,$	Switch ON or OFF		160	300	μΑ
C _{in}	Control inputs	V _{DD} = 1.9 V,	$V_{IN} = V_{DD}$ or GND			0.5	1.0	pF
C _{IO(OFF)}	SB or DA port	$V_{I/O} = 0 V$,	Switch OFF			1.4	1.5	pF
C _{IO(ON)}		$V_{I/O} = 0 V$,	Switch ON			3.5	4	pF
_		V _{DD} = 1.7 V,	V _I = 0 V,	I _O = 10 mA		10	14	Ω
r _{on}		V _{DD} = 1.7 V,	V _I = 1.5 V,	I _O = -10 mA		12	17	2.2
$\Delta r_{on(flat)}$		V _{DD} = 1.7 V,	I _O = 10 mA,	$V_{I} = 1.5 \text{ V} \pm 0.4 \text{ V}$		2.5	5	Ω

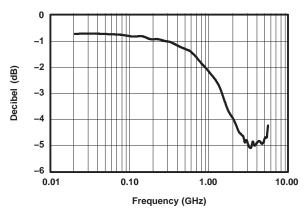
Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	DESCRIPTION	TEST CONDITIONS	T _A =	UNIT		
PARAMETER	DESCRIPTION	TEST CONDITIONS	MIN	TYP	MAX	UNII
DR	Data rate per TX or RX pair			2.5		Gbps
t _{pd}	Propagation delay, Sx to Dx	See Figure 7		250		ps
t _{sk}	Intra-pair skew	f =1.25 GHz, See Figure 7			5	ps
t _{en} (t _{PZL} , t _{PZH})	Switch turn-on delay, CTRL to DA	See Figure 6			5	ns
t _{dis} (t _{PLZ} , t _{PHZ})	Switch turn-off delay, CTRL to DA	See Figure 6			2.5	ns
I _{LOSS}	Differential insertion loss	f =1.25 GHz, R_{LOAD} = 50 Ω , See Figure 1		-2.5	-3.2	dB
R _{LOSS}	Differential return loss	f =1.25 GHz, R_{LOAD} = 50 Ω , See Figure 2	-7.2	-9.5		dB
I _{LOSS(CM)}	Common-mode insertion loss	f =1.25 GHz, R_{LOAD} = 50 Ω , See Figure 3		-2		dB
O _{IFF}	Differential OFF isolation	f =1.25 GHz, R_{LOAD} = 50 Ω , See Figure 4	-33	-38		dB
X _{TALK}	Differential crosstalk	f =1.25 GHz, R_{LOAD} = 50 Ω , See Figure 5	-33	-39		dB



OPERATING CHARACTERISTICS



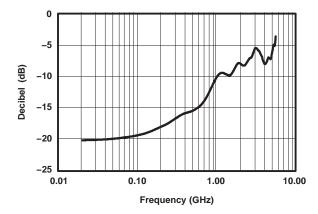


Figure 1. Differential Insertion Loss vs Frequency

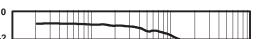
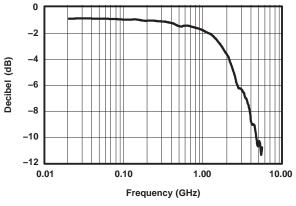


Figure 2. Differential Return Loss vs Frequency



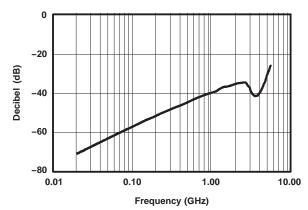


Figure 3. Common-Mode Insertion Loss vs Frequency

Figure 4. Differential OFF Isolation vs Frequency

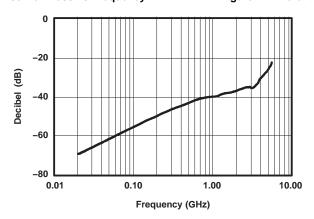
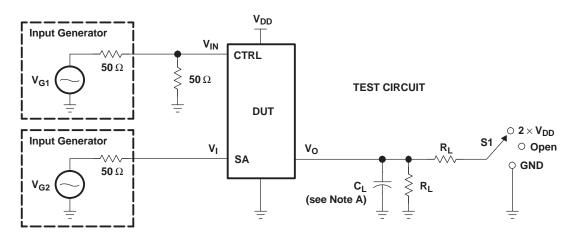


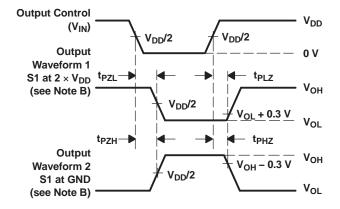
Figure 5. Differential Crosstalk vs Frequency



PARAMETER MEASUREMENT INFORMATION (Enable and Disable Times)



TEST	V _{CC}	S1	R_{L}	VI	CL	${f V}_{\Delta}$
t_{PLZ}/t_{PZL}	1.8 V ± 0.1 V	$2 \times V_{DD}$	100 Ω	GND	No Load	0.3 V
t _{PHZ} /t _{PZH}	1.8 V ± 0.1 V	GND	100 Ω	V_{DD}	No Load	0.3 V



VOLTAGE WAVEFORMS ENABLE AND DISABLE TIMES

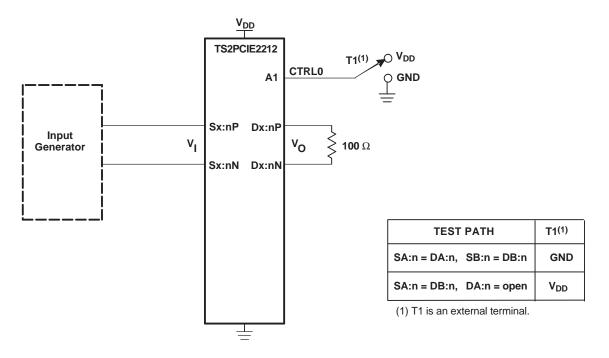
NOTES: A. C_L includes probe and jig capacitance.

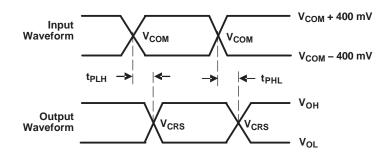
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , $t_f \leq$ 2.5 ns. $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en}.

Figure 6. Test Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION





 $V_{COM} = 1.5 V$

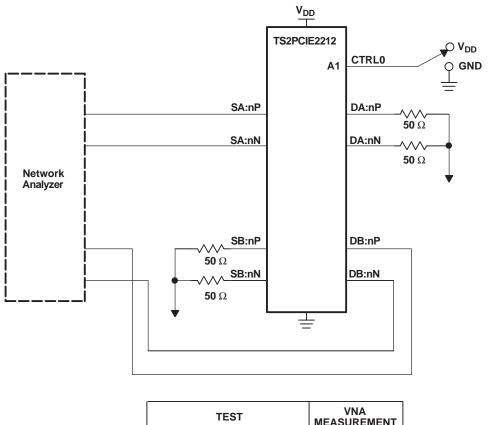
 $\ensuremath{\text{V}_{\text{CRS}}}\xspace$ is the cross point of the differential signal.

 $t_{sk} = |t_{PLHn} - t_{PHLn}|$

Figure 7. Test Circuit for Propagation Delay and Intra-Pair Skew



PARAMETER MEASUREMENT INFORMATION (continued)

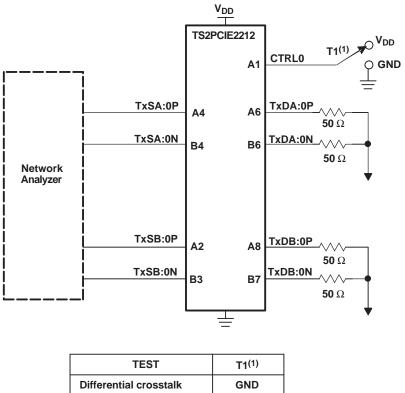


TEST	VNA MEASUREMENT
Differential insertion loss	S ₂₁
Differential return loss	S ₁₁
Common-mode insertion loss	S ₂₁

Figure 8. Differential Insertion Loss, Differential Return Loss, and Common-Mode Insertion Loss Test Circuit



PARAMETER MEASUREMENT INFORMATION (continued)



TEST	T1 ⁽¹⁾
Differential crosstalk	GND
Differential OFF isolation	V _{DD}

(1) T1 is an external terminal.

Figure 9. Differential Crosstalk and OFF Isolation Test Circuit



PACKAGE OPTION ADDENDUM

20-May-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	U	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)		(3)		(4/5)	
TS2PCIE2212ZAHR	ACTIVE	NFBGA	ZAH	48	3000	Pb-Free (RoHS)	SNAGCU	Level-3-260C-168 HR	0 to 85	SE212	Samples
TS2PCIE2212ZAHRG1	ACTIVE	NFBGA	ZAH	48	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-3-260C-168 HR		SE212	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

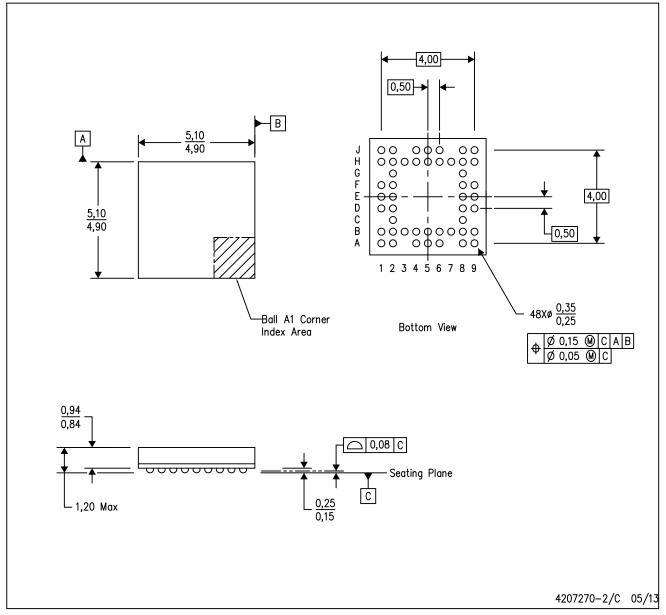
- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

ZAH (S-PBGA-N48)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y1.5M-1994.

- B. This drawing is subject to change without notice.
- C. JEDEC MO-225 registration is pending.
- D. This is a Pb-free solder ball design.



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive Communications and Telecom **Amplifiers** amplifier.ti.com www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps

DSP **Energy and Lighting** dsp.ti.com www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical logic.ti.com Logic Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

RFID www.ti-rfid.com

OMAP Applications Processors www.ti.com/omap TI E2E Community e2e.ti.com

Wireless Connectivity <u>www.ti.com/wirelessconnectivity</u>